Effects of Tetrahedral Fe²⁺ on the Structural, Magnetic and Electronic Properties of Solution-based Titanomagnetite Thin Films

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Polycrystalline titanomagnetite ($Ti_xFe_{3-x}O_4$) thin films prepared by using a sol-gel process exhibited a phase-pure spinel (Fd3m) structure for Ti compositions up to x=0.6. An X-ray photoelectron spectroscopy (XPS) investigation disclosed an increase of the Fe^{2+} concentration with increasing x, indicating a reduction in ionic valence, $Fe^{3+} \rightarrow Fe^{2+}$, induced by Ti^{4+} occupation of the cationic sublattice. Analyses on XPS and X-ray diffraction spectra of the $Ti_xFe_{3-x}O_4$ samples suggest that the Fe^{2+} ions prefer the tetrahedral sites while the Ti^{4+} ions prefer the octahedral sites of the sublattice. Magnetic hysteresis measurements on the $Ti_xFe_{3-x}O_4$ films revealed significant loss of the saturation magnetization (M_s) with increasing x: M_s is reduced to 50% that of Fe_3O_4 for x=0.10 and to 10% for x=0.60. The big loss of M_s caused by small Ti doping suggests a significant disruption of the inter-site $Fe^{3+}-Fe^{3+}$ super-exchange interaction in thin-film titanomagnetites.

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